TRENDware TEW-228PI EMC Test Report

Declaration of Conformity

We, the under signed,

Company	TRENDware International, Inc.	
Address, City	3135 Kashiwa Street, Torrance, CA 90505,	
Country	USA	
Phone number	310-891-1100	
Fax number	310-891-1111	
E-mail		

certify and declare under our sole responsibility that the following equipment:

Product Description / Supplementary Info	802.11b Wireless LAN PCI Adapter
Manufacturer	TRENDware International, Inc.
Brand	TRENDware
Туре	TEW-228PI

is tested to and conforms with the essential radio test suites included in the following standards:

Standard	Issue date
ETSI EN 300 328-2	V1.2.1 Dec. 2001
ETSI EN 301 489-1	V1.4.1 Aug. 2002
ETSI EN 301 489-17	V1.2.1 Apr. 2002
EN 60950	2000

and therefore complies with the essential requirements and provisions of the **R&TTE** directive **1999/5/EC** of the European Parliament and of the council of 9March 1999 on radio equipment and Telecommunications Terminal Equipment and the mutual recognition of their conformity and the requirements of Annex III (conformity Assessment procedure referred to in article 10(4)).

The technical documentation as required by the Conformity Assessment procedure is kept at the following address:

Company	TRENDware International, Inc.	
Address, City	3135 Kashiwa Street, Torrance, CA 90505,	
Country	USA	
Phone number	310-891-1100	
Fax number	310-891-1111	
E-mail		



Draw up in	USA		
Date	2004/02/20		
	TRENDware International, Inc.		
	3135 Kashiwa Street, Torrance, CA 90505, USA		
Signature & company sta	amp Mr. Pei C. Huang / President		

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Report No. C51ET143

Specifications | ETSI EN 301 489-1 V1.4.1 (August, 2002)

ETSI EN 301 489-17 V1.2.1 (August, 2002)

Applicant TRENDware International, Inc.

Applicant 3135 Kashiwa Street Torrance, CA 90505, USA

address

Items tested 802.11b Wireless LAN PCI Adapter

Model No. TEW-228PI

EUT Condition Engineering sample; Pre-production; Final production

(Sample # C51638)

Results Compliance (As detailed within this report)

Date 04/30/2003 (month / day / year) (Sample received)

05/15/2003 (month / day / year) (Test)

Prepared by Project Engineer (Jack Tsai)

(Jack Tsai)

Authorized by

General Manager
(Frank Tsai)

Issue date February 21, 2004 (month / day / year)

Modifications None

Tested by Training Research Co., Ltd.

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Conditions of issue:

This test report shall not be reproduced except in full, without written approval of TRC. And the test result contained within this report only relate to the sample submitted for testing.

★ Aut. No. ELA 131

Generally Statement:

The results appear in the following order:

Electromagnetic compatibility and radio spectrum matters (ERM); Electro Magnetic Compatibility (EMC) standard for radio equipment and services;

Part 1: Common Technical requirements

Part 17: Specific conditions for Wideband data and HIPERLAN equipment.

The results exhibits below only apply to particular samples tested and to the specific tests carried out, as detailed in this Test Report. The issue of this Test Report does not indicate any measure of Approval, Certification, Supervision, Control or Surveillance by Training Research Co., Ltd. of any product. No extract, abridgement or abstraction from a Test Report may be published or used to advertise a product without the written consent of the Director, Training Research Co., Ltd. who reserves the absolute right to agree or reject all or any of the details of any item of publicity for which consent may be sought.

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Chapter 0 Emission and Susceptibility Standards

Emission Standards

Emission Standard	European Standard	International Standard
()	EN 61000-6-3/2001	IEC 61000-6-1/1996
()	EN 61000-6-4/2001	IEC 61000-6-1/1997
()	EN 50081-1/1992	
()	EN 50081-1/8.93	
()	EN 55014/4.93	CISPR 14: 1993
()	EN 55015/12.93	CISPR 15: 1992
()	EN 55011/91	CISPR 11: 1990
(X)	EN 55022/98	CISPR 22: 1997
(X)	EN 61000-3-2/2000	IEC 61000-3-2: 2000 (Modified)
(X)	EN 61000-3-3/1995	IEC 61000-3-3: 1994 + A1/2001

Susceptibility Standards

Susceptibility Standard	European Standard	International Standard
()	EN 61000-6-1/2001	IEC 61000-6-1/1997
()	EN 61000-6-2/2001	IEC 61000-6-1/1999
()	EN 50082-1/1997	
()	EN 50082-2/1994	
()	EN 55024/1998	CISPR 24/1997
()	EN 55020/2002	CISPR 20/2002
(X)	EN 61000-4-2:1995	IEC 61000-4-2:1995
(X)	EN 61000-4-3:1996	IEC 61000-4-3:1995
(X)	EN 61000-4-4:1995	IEC 61000-4-4:1995
(X)	EN 61000-4-5:1995	IEC 61000-4-5:1995
(X)	EN 61000-4-6:1996	IEC 61000-4-6:1996
()	EN 61000-4-8:1993	IEC 61000-4-8:1993
(X)	EN 61000-4-11:1994	IEC 61000-4-11:1994
()	EN 55014-2:1993	CISPR/F (Sec) 159

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Chapter 1 Introduction

Description of EUT

Product Name : 802.11b Wireless LAN PCI Adapter

Model Name : TEW-228PI

Frequency Range : $2.400 \text{GHz} \sim 2.4835 \text{GHz}$

Operating Frequency: 2.412GHz ~ 2.472GHz

Support Channel: 13 Channels

Modulation Skill : DBPSK, DQPSK, CCK

Power Type : By the Protocol Control Information interface of computer

Data Cable : None

Test Method

1. Put the EUT into a personal computer's PCI bus and screw it.

- 2. Using the LAN port of computer and software provided by the manufacturer to control the EUT. The test is performed under those specific conditions.
- 3. Then making EUT to the following mode.
 - (a) EMI testing: making EUT to the linking mode with support equipments
 - (b) EMS testing: same as above

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List of Support Equipment

In order to construct the minimum testing, following equipment were used as the support units.

 PC
 : IBM 6840

 Model No.
 : 6840MJV

 Serial No.
 : 96CC 0BT

 FCC ID
 : DoC Approved

 檢磁
 : 3892I279

Power type : $100 \sim 127/200 \sim 240 \text{VAC}$, 4A/2A 50/60 Hz, Switching Power cord : Non-shielded, 182cm length, Plastic hood, No ferrite core

PC : ASUSTek Computer Inc.

Model No. : Terminator P4 AB-T2 101

Serial No. : 2CPMA31477 FCC ID : DoC Approved

BSMI : R31018

Power type : $100 \sim 127/200 \sim 240$ VAC, 4A/2A 47/63 Hz, Switching Power cord : Non-shielded, 182cm length, Plastic hood, No ferrite core

Monitor : HP 15' Color Monitor

Model No. : D2827A

Serial No. : KR91161716

FCC ID : C5F7NFCMC1518X

檢磁 : 3872B039

Power type : $110 \sim 240 \text{ VAC} / 50 \sim 60 \text{ Hz}$, Switching Power cord : Shielded, 1.83m long, No ferrite core

Data cable : Shielded, 1.46m long, with two ferrite cores

Keyboard : **HP** Model No. : 5181

Serial No.: BE21700405FCC ID: Doc Approved檢磁: 3892C981

Power type : By PC

Data cable : Shielded, 1.70m length, with ferrite core

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PS/2 Mouse : HP Model No. : M-S34

 Serial No.
 : LZB90714106

 FCC ID
 : DZL211029

 檢磁
 : 4862A011

Power type : By PC

Power cord : Non-shielded, 1.88m long, No ferrite core

Printer : HP

Model No. : C6464A

Serial No. : TH16LEB5PK

FCC ID : N/A, DoC Approved

檢磁 : 3892H381

Power type : Switching Adapter

Power cord : Non-shield, 173cm long, No ferrite core

(between adaptor and AC source)

Non-shielded, 180cm long, with ferrite core

(between printer and adaptor)

Data cable : Shielded, 1.70m long, No ferrite core

Fax/Modem: AceexModel No.: DM-1414Serial No.: 9010582

FCC ID : IFAXDM1414

Power type : $110 \text{ VAC} / 50 \sim 60 \text{ Hz}$, Switching

Power Cord : Non-shielded, 1.90m long, Plastic hoods, and no ferrite bead Data Cable : RS-232→ Shielded, 1.30m long, Metal hoods , No bead

RJ-11Cx2→ Non-shielded, 7' long, Plastic hoods, No bead

USBGamepad : RockfireModel No. : QF-337UVSerial No. : KR91379759

FCC ID : None (CE approval)

Data cable : Shielded, 1.80m long, No ferrite core

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Notebook : ASUSTek Computer

Model No. : AB00F

Serial No. : 24NP016361 FCC ID : DoC Approved

BSMI : 41016012

Power type : $100 \sim 240 \text{VAC}$, 1A 50/60 Hz, Switching

Adaptor of

Notebook : LITE-ON Electronics, Inc.

Model No. : PA-1530-01 Serial No. : 00151184

FCC ID : DoC Approved 檢磁 : 3882B259

Power cable : Non-shielded, 1.72m length, Plastic hood, No ferrite core

(Between power adaptor and AC power source)

Power cable : Shielded, 1.48m length, Plastic hood, with ferrite core

(Between power adaptor and notebook)

WLAN Card : Gemtek Technology Co., Ltd.

Model No. : C911003

FCC ID : MXF-C911003

Chapter 2 Emission and Immunity Requirements Overview

Emission (ETSI EN 301 489-1)

Phenomenon	Application		Equipment test requirement		
		Radio and	Radio and	Radio and	Subclause in
		ancillary	ancillary	ancillary	the present
		equipment for	equipment for	equipment for	document
		fixed use (base	vehicular use	portable use	
		station	(mobile	(portable	
		equipment)	equipment)	equipment)	
Radiated	Enclosure of	Applicable for	Applicable for	Applicable for	8.2
emission	ancillary	stand alone	stand alone	stand alone	
	equipment	testing	testing	testing	
Conducted	DC power	Applicable	Applicable	Not applicable	8.3
emission	input/output				
	port				
Conducted	AC mains	Applicable	Not applicable	Not applicable	8.4
emission	input/output				
	port				
Harmonic	AC mains input	Applicable	Not applicable	Not applicable	8.5
current	port				
emissions					
Voltage	AC mains input	Applicable	Not applicable	Not applicable	8.6
fluctuations	port				
and flicker					

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Immunity (ETSI EN 301 489-1)

Phenomenon	Application	Equipment test requirement		Reference	
		Radio and	Radio and	Radio and	Subclause in
		ancillary	ancillary	ancillary	the present
		equipment for	equipment for	equipment for	document
		fixed use (base	vehicular use	portable use	
		station	(mobile	(portable	
		equipment)	equipment)	equipment)	
RF	Enclosure	Applicable	Applicable	Applicable	9.2
electromagnetic					
field (80MHz to					
1GHz)					
Electrostatic	Enclosure	Applicable	Applicable	Applicable	9.3
discharge					
Fast transients	Signal,	Applicable	Not	Not	9.4
common mode	telecommunication		applicable	applicable	
	and control ports,				
	DC and AC power				
	ports				
RF common	Signal,	Applicable	Applicable	Not	9.5
mode 0.15 MHz	telecommunication			applicable	
to 80MHz	and control ports,				
	DC and AC power				
	ports				
Transients and	DC power input	Not applicable	Applicable	Not	9.6
surges	ports			applicable	
Voltage dips and	AC mains power	Applicable	Not	Not	9.7
interruptions	input ports		applicable	applicable	
Surges, line to	AC mains power	Applicable	Not	Not	9.8
line and line	input ports,		applicable	applicable	
ground	telecommunication				
	ports				

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Chapter 3 Performance Criteria

ETSI EN 301 489-17, Subclause 6.2

	Table 1 Performance criteria			
Criteria	During test	After test		
A	Shall operate as intended	Shall operate as intended		
	May show degradation of	Shall be no degradation of performance		
	performance (NOTE 1)	(NOTE 2)		
	Shall be no loss of function	Shall be no loss of function		
	Shall be no unintentional	Shall be no loss of stored data or user		
	transmissions	programmable functions		
В	May show loss of function (one or	Function shall be self-recoverable		
	more)	Shall operate as intended after recovering		
	May show degradation of	Shall be no degradation of performance		
	performance (NOTE 1)	(NOTE 2)		
	No unintentional transmissions	Shall be no loss of stored data or user		
		programmable functions		
C	May be loss of function (one or	Functions shall be recoverable by the		
	more)	operator		
		Shall operate as intended after recovering		
		Shall be no degradation of performance		
		(NOTE 2)		

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NOTE 1:

Degradation of performance during the test is understood as a degradation to a level not below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance.

If the minimum performance level or the permissible performance degradation in not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect form the apparatus if used as intended.

NOTE 2:

No degradation of performance after the test is understood as no degradation below a minimum performance level specified by the manufacturer for the use of the apparatus as intended. In some cases the specified minimum performance level may be replaced by a permissible degradation of performance. After the test no change of actual operating data or user retrievable data is allowed.

If the minimum performance level or the permissible performance degradation in not specified by the manufacturer then either of these may be derived from the product description and documentation (including leaflets and advertising) and what the user may reasonably expect form the apparatus if used as intended.

ETSI EN 301 489-1

Performance criteria for Continuous phenomena applied Transmitters (CT)

If no further details are given in the relevant part of the present document dealing with the particular type of radio equipment, the following *general performance criteria for continuous phenomena* shall apply.

During and after the test:

The apparatus shall continue to operate as intended. No *degradation of performance* or *loss of function* is allowed below a permissible performance level specified by the manufacturer when the apparatus is used as intends. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the test:

The EUT shall not unintentionally transmit or change its actual operating state and stored data. If the *minimum performance level* or the *permissible loss* is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect form the apparatus if used as intended.

For ancillary equipment the pass/failure criteria supplied by the manufacturer (see subclause 6.4) shall apply, unless the ancillary equipment is tested in connection with a receiver or transmitter in which case the corresponding performance criteria above shall apply.

Performance criteria for Transient phenomena applied Transmitters (TT)

If no further details are given in the relevant part of the present document dealing with the particular type of radio equipment, the following *general performance* criteria for transient phenomena shall apply.

After the test:

The apparatus shall continue to operate as intended. No *degradation of performance* or *loss of function* is allowed below a permissible performance level specified by the manufacturer when the apparatus is used as intends. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the test:

The EMC exposure to an electromagnetic phenomenon, a *degradation of performance* is, however, allowed. No change of the actual mode of operation (e.g. unintended transmission) or stored data is allowed.

If the minimum performance level or the permissible loss is not specified by the manufacturer, Then either of these may be deduced from the product description and documentation and what the user may reasonably expect form the apparatus if used as intended.

For ancillary equipment the pass/failure criteria supplied by the manufacturer (see subclause 6.4) shall apply, unless the ancillary equipment is tested in connection with a receiver or transmitter in which case the corresponding performance criteria above shall apply.

Performance criteria for Continuous phenomena applied Receivers (CR)

If no further details are given in the relevant part of the present document dealing with the particular type of radio equipment, the following *general performance* criteria for continuous phenomena shall apply.

During and after the test:

The apparatus shall continue to operate as intended. No *degradation of performance* or *loss of function* is allowed below a permissible performance level specified by the manufacturer when the apparatus is used as intends. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the test:

The EUT shall not unintentionally transmit or change its actual operating state and stored data. If the minimum performance level or the permissible loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect form the apparatus if used as intended.

For ancillary equipment the pass/failure criteria supplied by the manufacturer (see subclause 6.4) shall apply, unless the ancillary equipment is tested in connection with a receiver or transmitter in which case the corresponding performance criteria above shall apply.

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Performance criteria for Transient phenomena applied Receivers (TR)

If no further details are given in the relevant part of the present document dealing with the particular type of radio equipment, the following *general performance* criteria for transient phenomena shall apply.

After the test:

The apparatus shall continue to operate as intended. No *degradation of performance* or *loss of function* is allowed below a permissible performance level specified by the manufacturer when the apparatus is used as intends. In some cases this permissible performance level may be replaced by a permissible loss of performance.

During the test:

The EMC exposure to an electromagnetic phenomenon, a degradation of performance is, however, allowed. No change of the actual mode of operation (e.g. unintended transmission) or stored data is allowed.

If the minimum performance level or the permissible loss is not specified by the manufacturer, then either of these may be deduced from the product description and documentation and what the user may reasonably expect form the apparatus if used as intended.

For ancillary equipment the pass/failure criteria supplied by the manufacturer (see subclause 6.4) shall apply, unless the ancillary equipment is tested in connection with a receiver or transmitter in which case the corresponding performance criteria above shall apply.

ETSI EN 301 489-17

Performance criteria for Continuous phenomena applied Transmitters (CT)

The performance criteria A shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In systems using acknowledgement signals, it is recognized that an ACKnowledgement (ACK) or Not ACKnowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Transient phenomena applied Transmitters (TT)

The performance criteria B shall apply, except for voltage dips of 100ms and voltage interruptions of 5000 ms duration, for which performance criteria C shall apply.

Tests shall be repeated with the EUT in standby mode (if applicable) to ensure that unintentional transmission does not occur. In system using acknowledgement signals, it is recognized that an acknowledgement (ACK) or not-acknowledgement (NACK) transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of the test is correctly interpreted.

Performance criteria for Continuous phenomena applied Receivers (CR)

The performance criteria A shall apply.

Where the EUT is a *transceiver*, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of test is correctly interpreted.

Performance criteria for Transient phenomena applied Receivers (TR)

The performance criteria B shall apply, except for voltage dips of 100ms and voltage interruptions of 5000 ms duration, for which performance criteria C shall apply.

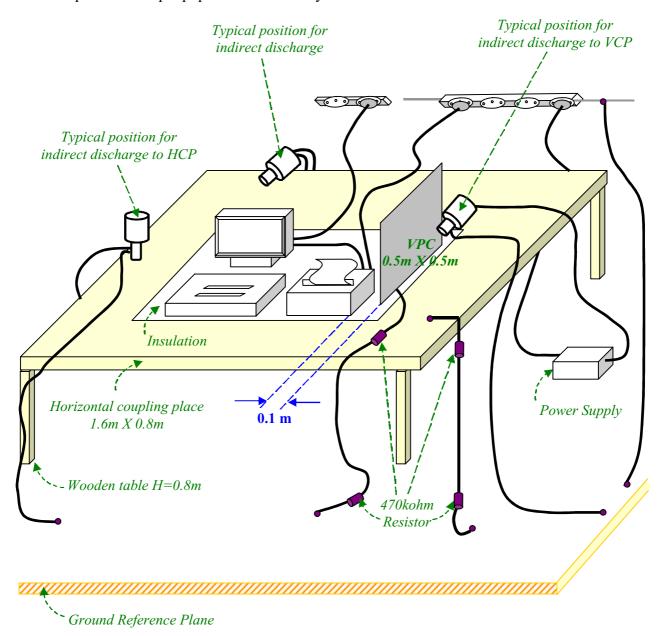
Where the EUT is a *transceiver*, under no circumstances, shall the transmitter operate unintentionally during the test. In systems using acknowledgement signals, it is recognized that an ACK or NACK transmission may occur, and steps should be taken to ensure that any transmission resulting from the application of test is correctly interpreted.

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Chapter 4 Electrostatic Discharges Immunity Test

ESD Test information:

Test setup: Shielded room, According to EN 61000-4-2 Test setup for table-top equipment at laboratory tests:



Test levels: (Apply Level 2 and Level 3)

1a —Contact discharge		1b —Air discharge		
Level	Test voltage	Test voltage Level		
	(kV)		(kV)	
1	2	1	2	
2	4	2	4	
3	6	3	8	
4	8	4	15	
X	Special	X	Special	

NOTE: "X" is an open level. The level has to be specified in the dedicated equipment specification. If higher voltages than those shown are specified, special test equipment may be needed.

Test Voltage: (X) 4KV contact discharge (X) 8KV air discharge

Indirect Discharges: (X) HCP (X) VCP **Polarity:** (X) Positive (X) Negative

Test mode: Ref. Test method of Chapter 1

Test points: Each connector and enclosure of EUT.

Test instruments:

Name	Model Number	Serial Number	Selected
Best Plus BURST ESD	Best Plus V6.2	199749-019SC	
SURGE TRANSIENTS			
BEST EMC Test	BEST EMC V2.3	199918-006SC	
Instrument	(-8, -9)		
KeyTek Instrument	Series 2000	9204303/9204310	X
ESD Test system		9209226/9301395	
NoiseKen Electrostatic	ESS-100L(A)	2100C03605	
Discharge Simulator			
NoiseKen Electrostatic	TC-815P	2100C03566	
Discharge Gun			

Comment:

Performance Criteria: (According to ETSI EN 301 489-1)

(X) Enclosure	()CT	(X)TT	() CR	(X)TR
(X) Signal and control ports	()CT	(X)TT	() CR	(X)TR

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EN 61000-4-2 PHOTO OF TEST SET-UP

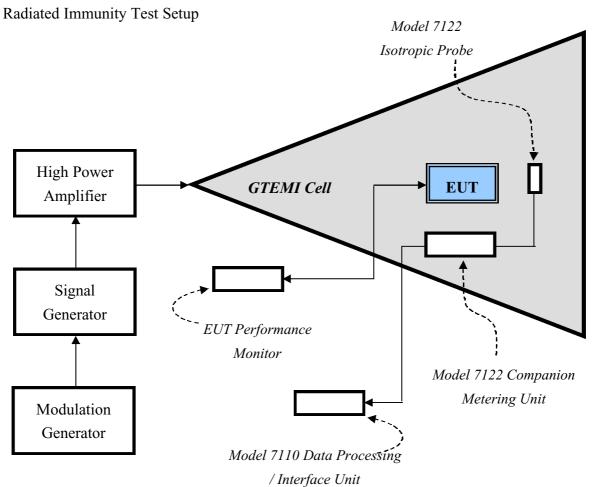


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Chapter 5 Radio Frequency Immunity Test (RS)

RS Test information:

Test setup: GTEM cell



Test levels: (Apply Level 2)

Level	Test Field Strength
	(V/m)
1	1
2	3
3	10
X	Special
NOTE: the "X" is an open test level. This leve	I may be given in the product specification.

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Field strength: (X) 3V/m at $80 \sim 800$ MHz

(X) 10V/m at 800 ~ 960 MHz (X) 3V/m at 960 ~ 1000 MHz (X) 10V/m at 1400 ~ 2000 MHz

Modulation: () FM %

(X) 80% AM Modulation with 1KHz

() 80% AM Modulation with 400Hz when signal is modulated at 1kHz

() 900 KHz± 5 KHz with PM 200 Hz and 100% depth

Step size: (X) 1% step size Sweep time: (X) 2.5 Second

Test mode: Ref. Test method of Chapter 1

Test instruments:

Name	Model Number	Serial Number	Selected
EMCO GTEM	5317	9411-1123	X
EMCO Probe	7122	9406-1194	X
EMCO METERING UNIT	7122	9406-1194	X
EMCO data interface	7110	9410-1273	X
HP Personal Computer	D3178A	3438S00486	X
HP Signal Generator	8657B	2928U00286	X
HP Signal Generator	83711A	3429A00434	X
IFI Wideband Amplifier	SMX50	467-0795	X
Min-circuit Amplifier	GFL-2500VH	N/A	X
WG radiation meters	EMC-20	BN2244129	X
WG E-filed	2244 / 90.20	Z-0001	X
HP Transmission Test Set	4935A	3115A24046	X
B & K Precision Sound Level Meter	Type 2232	1810564	X

Comment:

Performance Criteria: (According to ETSI EN 301 489-1)

(X) Enclosure (X)CT ()TT (X)CR ()TR

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EN 61000-4-3 PHOTO OF TEST SET-UP





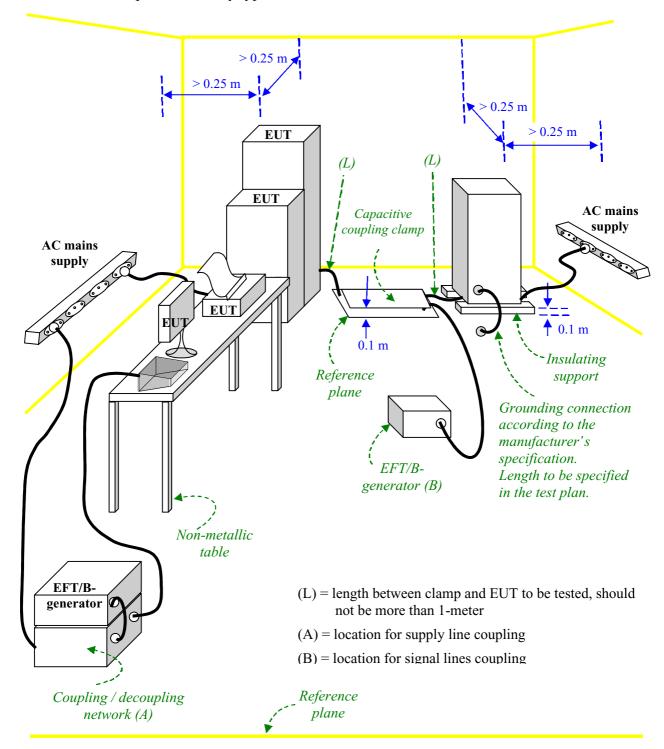
Report No.: C51ET143 (ETSI EN301489)

Training Research Co., Ltd., TEL: 886-2-26935155, Fax: 886-2-26934440

Chapter 6 Electric Fast Transient/Burst Requirements Test

EFT Test information:

General test set-up for laboratory type tests:



Test levels: (Apply Level 2)

Open-circuit output test voltage (±10%) and repetition rate of the impulses (±20%)						
	On power su	pply port, PE	On input/output signal, data and			
Laval			contro	control ports		
Level	Voltage peak	Repetition rate	Voltage peak	Repetition rate		
	kV	kHz	kV	kHz		
1	0.5	5	0.25	5		
2	1	5	0.5	5		
3	2	5	1	5		
4	4	2.5	2	5		
X	Special	Special	Special	Special		
NOTE: the "V" is an area level. The level has to be smoothed in the dedicated assignment smoothesticn.						

110 1 L. tile 11 15	un open	i icvei. The icvei h	as to	be specified in the dear	carca c	equipment specimente	11
Test setup: Accor	ding to	EN 61000-4-4					
Test Voltage:	DC P	ower line	() 0.5 KV, 5 KH			
	AC P	ower line	(X) 1 KV, 5 KHz			
	Signa	l & Control line	() 0.5 KV, 5 KHz; () 1 K	CV, 5 KHz	
Polarity:	(X)I	Positive	(X) Negative			
Test Duration:	(X)	1 minute	() 3 minutes			
Connected lines:	lines: () Power line shielded (X) Power line non-shielded						
	()	Signal & Control	line	non-shielded () Si	gnal &	& Control line shield	led
Test mode: Ref. 7	est me	ethod of Chapter	1.				
Test instrument:							
Name		Model Number		Serial Number		Selected	
Best Plus BURST	ESD	Best Plus V6.2		199749-019SC			
SURGE TRANSII	ENTS						
BEST EMC Test		BEST EMC V2.	3	199918-006SC			
Instrument		(-8, -9)					

Comment: Performance Criteria: (According to ETSI EN 301 489-1)

KeyTek Instrument E412

EFT Test system

1 chiomianee chicera. (11ccol	umg to ETDI	E 11 501 107 1)		
() Signal and control ports	()CT	()TT	() CR	()TR
() DC power input ports	()CT	TT()	() CR	()TR
(X) AC mains input ports	()CT	(X)TT	() CR	(X)TR

9505206/505207

X

Test Report ------ 26/43

EN 61000-4-4 PHOTO OF TEST SET-UP



Test Report ------ 27/43

Chapter 7 Surge Immunity Test

Surge Test information:

Test setup: According to *EN 61000-4-5* **Test levels:** (Apply Level 2 and Level 3)

Level	Test Field Strength
	(kV)
1	0.5
2	1.0
3	2.0
4	4.0
X	Special
NOTE: the "X" is an open class. This level ma	y be specified in the product specification.

Test Voltage:	DC Power line	() 0.5 KV
	AC Power line	() Line – Line: 1KV
		() Line – Ground: 2KV
		(X) Line – Line: 0.5KV
		(X) Line – Ground: 1KV
	Control line	() 0.5 KV
	Signal	() 1 KV, () 0.5KV
Time:	(X) 1.2/50µs (8/20	Oµs)
Polarity:	(X) Positive	(X) Negative
Connected lines:	(X) Power line () Signal & 0	e noi Cont	

Test mode: Ref. Test method of Chapter 1.

Test Report ------ 28/43

Test instrument:

Name	Model Number	Serial Number	Selected
Best Plus BURST ESD Best Plus V6.2		199749-019SC	
SURGE TRANSIENTS			
BEST EMC Test	BEST EMC V2.3	199918-006SC	
Instrument	(-8, -9)		
KeyTek Pulsed-EMI	E103, 501B, E502B,	0008260 ~0008264,	X
Test System	E503, E505A,	0008254	
	E4552A		

Comment:

Performance	Criteria:	(According	to ETSI EN 301	480_1)
remonifice	Ciliciia.	(Accor umg	10 E 1 S1 EN 301	407-11

(X) AC mains input ports	()CT	(X)TT	() CR	(X)TR
() Signal and control ports	()CT	()TT	() CR	()TR

Test Report ------ 29/43

EN 61000-4-5 PHOTO OF TEST SET-UP

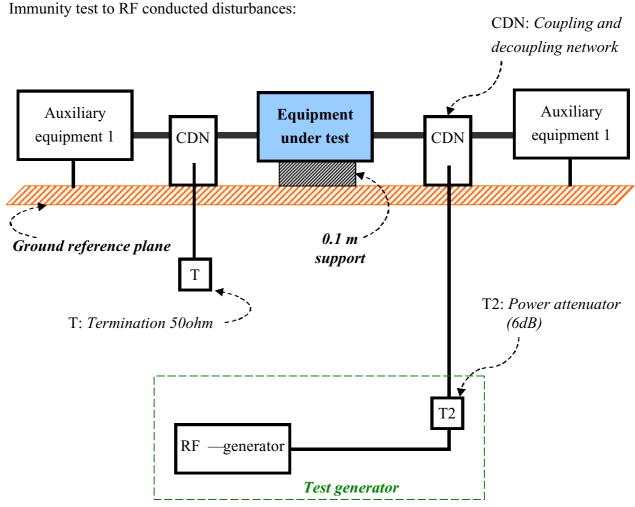


Test Report ----- 30/43

Chapter 8 Continuous Wave Voltage Immunity Test

CS Test information:

Test setup: According to EN 61000-4-6



Test levels: (Apply Level 2)

Frequency range 150kHz to 80MHz				
I1	Voltage lev	el (e.m.f.)		
Level	<i>U</i> o [dB(μv)]	Uo [V]		
1	120	1		
2	130	3		
3	140	10		
X Special				
NOTE: the "X" is an open test level.				

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Test Frequency:	(X) 0.15 ~ 80MHz
Modulation:	 () FM % (X) 80% AM Modulation with 1kHz () 80% AM Modulation with 400Hz when signal is modulated at 1kHz () 900 MHz± 5 MHz with PM 200 Hz and 50% duty cycle
Step size:	 (X) 50kHz step size in the frequency range 150kHz to 5MHz and 1% frequency increment of the momentary frequency in the frequency range 5MHz to 80MHz () 500kHz step size in the frequency range 150kHz to 5MHz and 10% frequency increment of the momentary frequency in the frequency range 5MHz to 80MHz for non-continuous duty cycle
Field strength:	() 1Vrms (X) 3Vrms () 10Vrms
Connected lines:	 () Power line shielded (X) Power line non-shielded () Signal & Control line non-shielded () Signal & Control line shielded

Test Report ----- 31/43

Test mode: Ref. Test method of Chapter 1

Test Report ----- 32/43

Test instruments:

Name	Model Number	Serial Number	Selected
FRANKONIA EMV–Mess–	CIT-10	103A3113	X
System			
FRANKONIA CDN	M2+M3	A3011015	X
FRANKONIA CDN	T2-801	A3010002	
FRANKONIA CDN	T4-801	A3015004	
FRANKONIA CDN	S1-801	A3005002	
SCHAFFNER FM-Koppelzange	KEMZ 801	17045	
SCHAFFNER RF-SYNTHE	NSG 2070-1	1020	
SIZERIAMP21FIER			
SCHAFFNER CDN	M325	13773	
SCHAFFNER CDN	M216	15604	
SCHAFFNER CDN	T004	15230	
SCHAFFNER CDN	S501	15167	
SCHAFFNER FM-Koppelzange	KEMZ 801	14301	
HP Transmission Test Set	4935A	3115A24046	
B & K Precision Sound Level Meter	Type 2232	1810564	

Comment:

Performance Criteria: (According to ETSI EN 301 489-1)

() Antenna port	()CT	TT()	() CR	()TR
() Signal and control ports	()CT	()TT	() CR	()TR
() DC power input ports	()CT	TT()	() CR	()TR
(X) AC mains input ports	(X)CT	TT()	(X)CR	()TR

Test Report ------ 33/43

EN 61000-4-6 PHOTO OF TEST SET-UP



Test Report	<i>t</i>	34/	43
L COU ILCDOI	y .	271	70

Chapter 9 Voltage DIP / Interruption Test

DIP	Test	in	form	atior	ı:

Test setup: According to EN 61000-4-11

Voltage dips: (X) 30%, 0.01 Second

() 60%, 0.1 Second

Voltage interruptions: (X) > 95%, 5 Seconds

Test mode: Ref. Test method of Chapter 1

Test instruments:

Name	Model Number	Serial Number	Selected
Best Plus BURST ESD	Best Plus V6.2	199749-019SC	
SURGE TRANSIENTS			
BEST EMC Test	BEST EMC V2.3	199918-006SC	
Instrument	(-8, -9)		
Partner EMS Tester	Transienter-1000	PIO	X

Comment:

<u>Performance</u>	Criteria:	(According	to ETSI	<i>EN 301</i>	<u> 489-1)</u>

Dips 30%:	(X	.) C1	() 1 1	(X	C) CR	() IK
Dips 60%:	() CT	() TT	() CR	() TR
Interruptions >95%:	() CT	() TT	() CR	() TR
No unintentional res	pon	ses shall oc	cur at	the end of the te	st;			
()Event of loss of	fun	ction(s)	()Event of loss of	of us	er stored data		
Performance Criter	<u>ia: (</u>	According	to ET	SI EN 301 489-	<i>17</i>)			
Dips 60%, 100 ms:			() A	() B	()	() C

() B

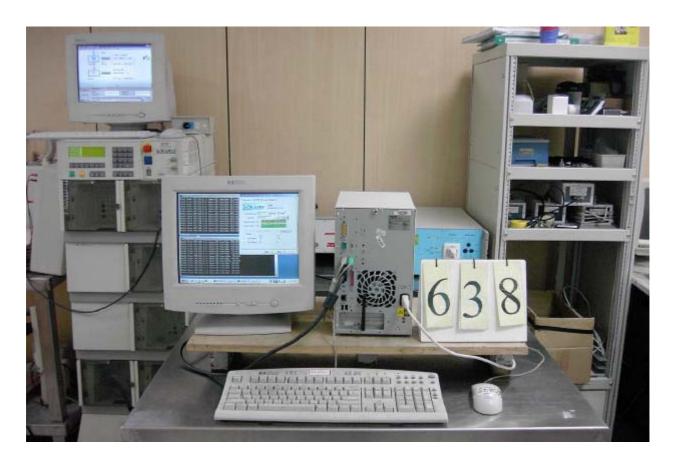
(X)C

Report No.: C51ET143 (ETSI EN301489)

Interruptions >95%, 5 000 ms: () A

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EN 61000-4-11 PHOTO OF TEST SET-UP



Chapter 10 Harmonics Test

Test information:

Test setup: According to EN 61000-3-2

Test item: Quasi – stationary & Fluctuating Current Harmonics Test.

Test mode: Ref. Test method of Chapter 1

Test instrument:

Name	Model Number	Serial Number	Selected
Harmonic/Flicker Test	HP 6842A	3531A-00102	X
System			

Test Equipment Settings:	Quasi-stationary Current	Fluctuating Current
	Harmonics Test	Harmonics Test
Line Voltage	230VAC	230VAC
Line Frequency	50Hz	50Hz
Device Class	D	D
Test Limit Overrides	None	None
Total Number of Failures:	None	None
Total Number of Errors:	None	None

Test Result: Pass

Chapter 11 Voltage Fluctuation and Flicker Test

Test information:

Test setup: According to *EN 61000-3-3* **Test mode:** Ref. Test method of Chapter 1

Test instrument:

Name	Model Number	Serial Number	Selected
Harmonic/Flicker Test	HP 6842A	3531A-00102	X
System			

Test Equipment Settings:

8	
Line Voltage	230VAC
Line Frequency	50Hz
Test Limit Overrides	None
Total Number of Failures:	Pst: (0), Plt: (0)
	Dc: (0), Dmax (0), Dt (0)
Total Number of Errors:	None

Test Result: Pass

Test Report ----- 38/43

Chapter 12 Conducted Emission Test

Test condition and setup

All the equipment is placed and setup according to *EN* 55022.

(1) Mains power:

The EUT is assembled on a wooden table, which is 80 cm high and placed 40 cm from the back-wall, which is a vertical conducting plane. One LISN is for EUT, the other LISN is for support equipment. They are all placed on the conductive ground. The EUT's LISN connect a line switch box for selecting L1 or L2, then connect to a preamplifier and spectrum.

(2) Telecommunication port:

The EUT is place as mains disturbance test. The communication line connected to ISN and then the measuring receiver connected to the ISN to measured the level of voltage disturbance.

The spectrum scans from 150KHz to 30MHz. Conducted emission levels are detected at *maximum peak mode*. But if the maximum peak mode failed or over *average limit*, it will be measured by *average detection mode*.

While testing the worst-emission plot printed in the *peak detection mode*, and there are up to 6 highest emissions to be recorded. The plot is kept as the original data and not included in the test report.

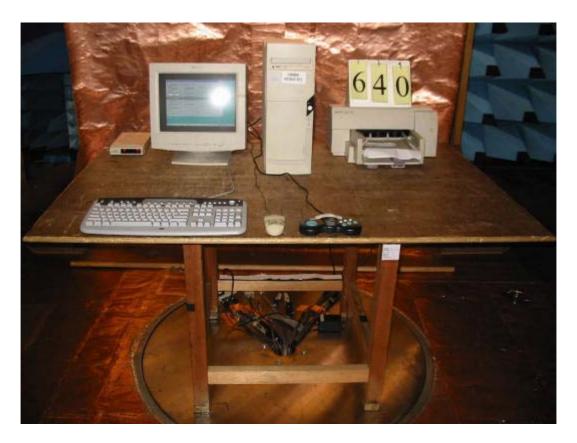
List of test Instrument

				<u>Calibration</u>	<u>n Date</u>
Instrument Name	Model No.	Brand	Serial No.	Last time	Next time
EMI Receiver	8546A	ΗP	3520A00242	06/28/02	06/28/03
RF Filter Section	85460A	ΗP	3448A00217	06/28/02	06/28/03
LISN (EUT)	LISN-01	TRC	9912-03,04	06/04/02	06/04/03
LISN (Support E.)	LISN-01	TRC	9912-05	07/15/02	07/15/03
ISN	ISN T400	Schaffne	r 16596	10/16/02	10/16/03
Auto Switch Box	ASB-01	TRC	9904-01	11/20/02	11/20/03
(< 30MHz)					

The level of confidence of 95%, the uncertainty of measurement of conducted emission is \pm 2.02 dB.

Test Report ------ 39/43

CONDUCTED EMISSION PHOTO OF TEST SET-UP





Report No.: C51ET143 (ETSI EN301489)

Training Research Co., Ltd., TEL: 886-2-26935155, Fax: 886-2-26934440

Test Result of Conducted Emissions for Mains power

Test Conditions: Temperature: 23.5 °C Humidity: 60.2 % RH

Test mode: Operating mode for Detachable antenna of EUT

Power Connected Emissions						Class B		
Conductor	Frequency (KHz)	Peak (dBµV)	QP (dBμV)	Average (dBμV)	QP-limit (dBµV)	AVG-limit (dBμV)	Margin (dB)	
	205.000	49.29			64.43	54.43	-5.14	
	405.000	40.18			58.71	48.71	-8.53	
	504.000	37.06			56.00	46.00	-8.94	
Line 1	587.000	32.65			56.00	46.00	-13.35	
	745.000	29.70			56.00	46.00	-16.30	
	1006.000	31.89			56.00	46.00	-14.11	
	2265.000	29.34			56.00	46.00	-16.66	
	3126.000	29.46			56.00	46.00	-16.54	
	203.000	48.45			64.49	54.49	-6.04	
	380.000	40.76			59.43	49.43	-8.67	
	409.000	40.02			58.60	48.60	-8.58	
Line 2	504.000	37.02			56.00	46.00	-8.98	
	1006.000	34.43			56.00	46.00	-11.57	
	1411.000	29.79			56.00	46.00	-16.21	
	1836.000	29.77			56.00	46.00	-16.23	
	2265.000	29.75			56.00	46.00	-16.25	

^{*}The reading amplitudes are all under limit.

Test mode: Standby mode for Detachable antenna of EUT

	Power Con	Class B					
Conductor	Frequency	equency Peak		QP Average		AVG-limit	Margin
	(KHz)	(dBµV)	(dBµV)	(dBµV)	(dBµV)	(dBµV)	(dB)
	203.000	47.38			64.49	54.49	-7.11
	409.000	41.33			58.60	48.60	-7.27
	504.000	36.36			56.00	46.00	-9.64
Line 1	581.000	31.94			56.00	46.00	-14.06
	998.000	31.68			56.00	46.00	-14.32
	1411.000	29.36			56.00	46.00	-16.64
	1854.000	30.12			56.00	46.00	-15.88
	3510.000	30.45			56.00	46.00	-15.55
	205.000	48.89			64.43	54.43	-5.54
	373.000	38.65			59.63	49.63	-10.98
	504.000	36.63			56.00	46.00	-9.37
Line 2	581.000	33.09			56.00	46.00	-12.91
	738.000	31.11			56.00	46.00	-14.89
	911.000	32.42			56.00	46.00	-13.58
	1333.000	30.38			56.00	46.00	-15.62
	2243.000	29.43			56.00	46.00	-16.57

^{*}The reading amplitudes are all under limit.

Test Report ------ 42/43

Chapter 13 Radiated Emission Test

Test condition and setup

Pretest: Prior to the final test (OATS test), the EUT is placed in a shielded enclosure, and scan from 30MHz to 1GHz. This is done to ensure the radiation is exactly emitted from the EUT. **Final test:** Final radiation measurements are made on a 10 -meter, open-field test site. The EUT is placed on a nonconductive table, which is 0.8m height, the top surface is 1.0×1.5 meter. The entire placement is according to EN 55022.

The whole range antenna is used to measure frequency from 30 MHz to 1GHz. The final test is used the spectrum analyzer (EMI Receiver). Measure more than six top marked frequencies generated form pretest by computer step by step at each frequency.

The EUT is rotated 360 degrees, and antenna is raised and lowered from 1 to 4 meters to find the maximum emission levels. The antenna is used with both horizontal and vertical polarization.

Appropriated preamplifier which is made by TRC is used for improving sensitivity and precautions is taken to avoid overloading .The spectrum analyzer's 6dB bandwidth is set to 120 kHz, and the EUT is measured at quasi-peak (below 1GHz) mode.

If the emission is close to the frequency band of ambient, the tester will recheck the data and the corrected data will be written in the test data sheet. If the emission is just within the ambient, the data from shielded room will be taken as the final data.

List of test Instrument

				Calibration Date	
Instrument Name	Model No.	Brand	Serial No.	Last time	Next time
Spectrum analyzer	8568B	ΗP	3004A18617	06/19/02	06/19/03
Quasi-peak Adapter	85650A	H P	2521A00984	06/20/02	06/20/03
RF Pre-selector	85685A	H P	2947A01011	06/20/02	06/20/03
Antenna	CBL6141A	SCHAFFNER	4188	11/29/02	11/28/03
Open test side (Anter	05/16/02	05/15/03			

The level of confidence of 95%, the uncertainty of measurement of radiated emission is \pm 3.44dB.

Test Report ------ 43/43

Test Result of Spurious Radiated Emissions

Test Conditions: Temperature : 23.5 ° C Humidity : 64.2 % RH

Test mode: 30MHz to 1GHz [Antenna polarity Horizontal]

Radiated Emission			Correction Factors	Corrected Amplitude	Clas (10		
Frequency (MHz)	Amplitude (dBµV)	Ant. H. (m)	Table (°)	(dB)	(dBµV/m)	Limit (dBµV/m)	Margin (dB)
71.22	16.54	1.00	136	1.97	18.51	30.00	-11.49
862.38	14.46	1.00	215	15.82	30.28	37.00	-6.72

Test mode: 30MHz to 1GHz [Antenna polarity Vertical]

Radiated Emission			Correction Factors	Corrected Amplitude	Clas (10		
Frequency (MHz)	Amplitude (dBµV)	Ant. H. (m)	Table (°)	(dB)	(dBµV/m)	Limit (dBµV/m)	Margin (dB)
71.22	16.09	1.00	199	1.97	18.06	30.00	-11.94
120.33	23.66	1.00	270	-1.27	22.39	30.00	-7.61
197.93	21.95	1.00	278	-2.64	19.31	30.00	-10.69
354.34	19.93	1.00	300	-1.20	18.73	37.00	-18.27

Note:

- 1. Margin = Amplitude limit, *if margin is minus means under limit*.
- 2. Corrected Amplitude = Reading Amplitude + Correction Factors
- 3. Correction factor = Antenna factor + (Cable Loss Amplitude gain)